



ISSN NO. 2320-5407

Journal homepage: <http://www.ijar.com>

INTERNATIONAL JOURNAL  
OF ADVANCED RESEARCH

## RESEARCH ARTICLE

## The characteristics of ZnO-MnO<sub>2</sub>-Bi<sub>2</sub>O<sub>3</sub>-Co<sub>2</sub>O<sub>3</sub>-TiO<sub>2</sub>-based varistor ceramics doped with Sb<sub>2</sub>O<sub>3</sub> and/or Cr<sub>2</sub>O<sub>3</sub>

Osama A. Desouky<sup>1</sup> and Mostafa M.H. Khalil<sup>2</sup><sup>1</sup> Higher Institute of Engineering (BHIE), Bilbis, Sharqia, Egypt<sup>2</sup> Chemistry Department, Faculty of Science, Ain Shams University, 11566 Abbassia, Cairo, Egypt

### Manuscript Info

#### Manuscript History:

Received: 11 December 2014  
Final Accepted: 25 January 2015  
Published Online: February 2015

#### Key words:

ceramics, ZnO, varistor, non-linear current-voltage behavior, Cr<sub>2</sub>O<sub>3</sub>, microstructure

#### \*Corresponding Author

Osama A. Desouky

### Abstract

The effect of Cr<sub>2</sub>O<sub>3</sub> and Sb<sub>2</sub>O<sub>3</sub> on the physical and electrical properties of ZnO-MnO<sub>2</sub>-Bi<sub>2</sub>O<sub>3</sub>-Co<sub>2</sub>O<sub>3</sub>-TiO<sub>2</sub>-based varistors ceramics were investigated in this work. The microstructure and electrical properties of varistors, which are composed of ZnO-MnO<sub>2</sub>-Bi<sub>2</sub>O<sub>3</sub>-Co<sub>2</sub>O<sub>3</sub>-TiO<sub>2</sub>-based varistors ceramics, were investigated in the range of (0.04 - 0.2) mol% Cr<sub>2</sub>O<sub>3</sub> samples (B1, B2 & B3) and 0.12 mol % of both Cr<sub>2</sub>O<sub>3</sub> and Sb<sub>2</sub>O<sub>3</sub> sample (Z1) or 0.12 mol% Cr<sub>2</sub>O<sub>3</sub> and 0.06 mol% Sb<sub>2</sub>O<sub>3</sub> (Z2). All samples exhibit non-linear current-voltage behavior. Addition of Bi<sub>2</sub>O<sub>3</sub> in present of Co<sub>2</sub>O<sub>3</sub>, MnO<sub>2</sub>, Sb<sub>2</sub>O<sub>3</sub> and Cr<sub>2</sub>O<sub>3</sub> lead better densification by minimizing the present of closed pores. Also maximum values of firing shrinkage were attained in specimens fired at 1220 °C for 2 hours. SEM of mix B1, shows two phase, ZnO grains and intergranular phase triple point, and TiO<sub>2</sub>, Co<sub>2</sub>O<sub>3</sub> and Cr<sub>2</sub>O<sub>3</sub> go into solid solution in the ZnO grains. Also Bi-rich phase in the triple point and increase the presence of liquid phase (melt liquid phase) on the grain boundary. The relation between I and V for the different mixes show very good plateau in (I-V) relation.

Copy Right, IJAR, 2015.. All rights reserved

## INTRODUCTION

ZnO is a very promising material for semiconductor device applications [1–5]. It has a direct and wide band gap in the near-UV spectral region [6–10], and a large free-exciton binding energy [6–9] so that excitonic emission processes can persist at or even above room temperature [11, 12]. ZnO crystallizes in the wurtzite structure, the same as GaN, but, in contrast, ZnO is available as large bulk single crystals [11]. Its properties have been studied since the early days of semiconductor electronics [13], but the use of ZnO as a semiconductor in electronic devices has been hindered by the lack of control over its electrical conductivity: ZnO crystals are almost always n-type, the cause of which has been a matter of extensive debate and research [1–5]. The physical properties of ZnO crystals depend strongly on the concentration of native defects caused by the deviation from the stoichiometric composition [14–17]. Zinc oxide varistors are a polycrystalline structured material consisting of semiconducting zinc oxide crystals and a second phase located at the boundaries of the crystals. This second phase consists of a certain number of metallic oxides (Bi<sub>2</sub>O<sub>3</sub>, MnO, Sb<sub>2</sub>O<sub>3</sub>, etc.). Thus, a zinc oxide varistor consists of a large number of boundaries forming a series-parallel network of resistors and capacitors, appearing somewhat like a multifunction semiconductor. Their excellent nonlinearly and electrical characteristics arising out of the grain boundaries are mostly dependent on the micro structural uniformity [18]. Ceramic processing results in semiconducting ZnO grains, with intergranular bismuth-rich oxide phases. The non-linear current–voltage characteristics are governed by the interfaces between the ZnO grains. The voltage-dependent resistivity results from Schottky barriers at ZnO-ZnO boundaries, but the Bi-rich phases present at multiple grain junctions also have a significant effect on the overall

resistivity [19–21]. In pure  $\text{Bi}_2\text{O}_3$ , the a monoclinic structure is the stable room temperature polymorph; on heating a transforms at  $730^\circ\text{C}$  to the oxygen ion conducting face centered cubic phase [22]. Often, in ceramic varistors at room temperature, the tetragonal  $\text{Bi}_2\text{O}_3$  phase [23–25] is reported, but there are also reports of the cubic y and g phases, as well as the a monoclinic form [26–30]. Originally, it was thought that the ZnO grains in the microstructure were separated by a continuous amorphous bismuth oxide layer [31,32]. Fabrication of ZnO varistors follow standard ceramic techniques. ZnO and other constituents are mixed by milling in a ball mill and dried by spraying. The mixture is pressed to the desired shape usually disc like. The resulting pellets are sintered at high temperature (typically  $1000\text{--}1400^\circ\text{C}$ ) [33]. The four basic compounds formed are ZnO, spinel, phrochlore and bismuth-rich phases. The phrochlore disappears at high temperature forming spinel and  $\text{Bi}_2\text{O}_3$  [34]. The observed current–voltage characteristics of a varistor are often empirically described by the power law relation:

$$J = C (E)^\alpha$$

Where J is the current density, E the applied electrical field,  $\alpha$  the coefficient of non-linearity and C is the proportionality constant that is related with the microstructure [35]. The aim of this work is to report experimental results that the doping of  $\text{Cr}_2\text{O}_3$  and  $\text{Sb}_2\text{O}_3$  to ZnO-MnO<sub>2</sub>- $\text{Bi}_2\text{O}_3$ -TiO<sub>2</sub>-Co<sub>2</sub>O<sub>3</sub>-based ceramic varistors improves the electrical properties. Small amounts of  $\text{Sb}_2\text{O}_3$  and/or  $\text{Cr}_2\text{O}_3$  limit ZnO grain growth and may affect the electrical properties.

## 2. Experimental

The powder was prepared using the mixed oxide method in alcoholic medium. All the oxides used were analytical grade: ZnO, MnO<sub>2</sub>,  $\text{Bi}_2\text{O}_3$ , TiO<sub>2</sub>,  $\text{Cr}_2\text{O}_3$  and  $\text{Sb}_2\text{O}_3$ . The molar compositions of the investigated systems were as shown in Table 1. The amounts of  $\text{Bi}_2\text{O}_3$ , Co<sub>2</sub>O<sub>3</sub> and TiO<sub>2</sub> were always kept constant, because these additives were used to facilitate densification during sintering. In this study, these compositions were chosen to evaluate the phenomena involved on the physical and electrical properties of this varistor system. Two discs were used, the first one has 1.2 cm diameter and 0.2 cm thickness, and the second disc has 5 cm diameter and 0.2 cm thickness. These two discs were processed by a semi-dry press method under 70 KN. The pellets were sintered at ( $800 - 1220^\circ\text{C}$ ) for 2 h in oxygen atmosphere and slowly cooled to room temperature ( $5^\circ\text{C}/\text{min}$ ). The optimum firing temperature for each mix was deduced from the determination of the following parameters; firing shrinkage, apparent porosity, bulk density and water absorption. The method given is according to the ASTM standard (C71, C72) [36]. The different mixes were examined by XRD. Using Philips apparatus type 170, a vanadium ( $\lambda = 1.54 \text{ \AA}$ ) and Ni-filter. In Metallurgy Research Center, Egypt. A continuous plot of intensity for  $2\theta$  values 4 to 80 was made at a scanning speed of  $1^\circ / \text{min}$ , with a paper speed of 10 mm/min. Mean grain size was determined by analyzing the SEM micrographies (Joel-JEM. T 200). To perform the electrical measurements, silver contacts were deposited on the sample surfaces. The (I-V) measurements of these samples were made by using a DC power supply in a current range up to 2 mA and pulse technique ( $8 \times 20 \mu\text{s}$  current pulses) for higher current ranges as described elsewhere. The non-linearity index ( $\alpha$ ) was calculated in a current range of 1 mA to 1 A using the following equation:

$$\alpha = (\text{Log } I_2 - \text{Log } I_1) / (\text{Log } V_2 - \text{Log } V_1)$$

Where  $I_1$  and  $I_2$  are the currents at the voltages  $V_1$  and  $V_2$ . The connection of varistors sample in electric circuit is show in Fig. 1.

The PM 6304 programmable automatic RCL meter was used for precise measurements of resistance, capacitance and inductance. From the measured values of capacitance, the dielectric constant at all frequency from 1 KHz- 200 KHz was calculated at constant temperature. The respective permittivity [ $\epsilon$ ] and conductivity [ $\sigma$ ] were calculated

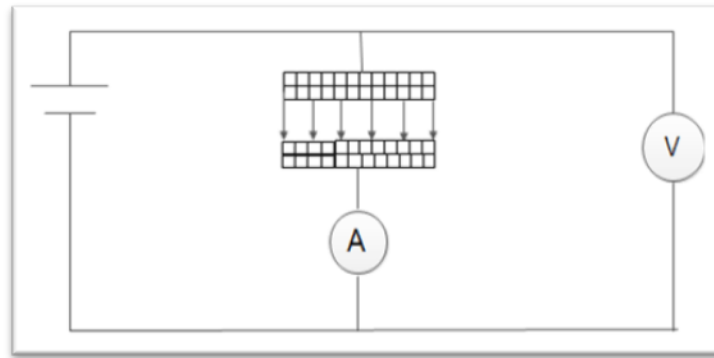
according to the following relations:  $\epsilon' = \frac{C d}{\epsilon_0 A}$ , where C = capacitance in Farad., d = thickness of

specimen in m.,  $\epsilon_0$  = dielectric constant of vacuum  $8.85 \times 10^{-12} \text{ F/m.}$ , A = area of specimen in  $\text{m}^2$ . Also from the values of resistance [R], the resistivity [ $\rho$ ] and conductivity [ $\sigma$ ] were calculated from the following relation:

Resistivity [ $\rho$ ] =  $\frac{R A}{d}$ , Where R: resistance, d = thickness of specimen in m., A = area of specimen in  $\text{m}^2$ .

**Table 1. Composition of different mixes in mol %**

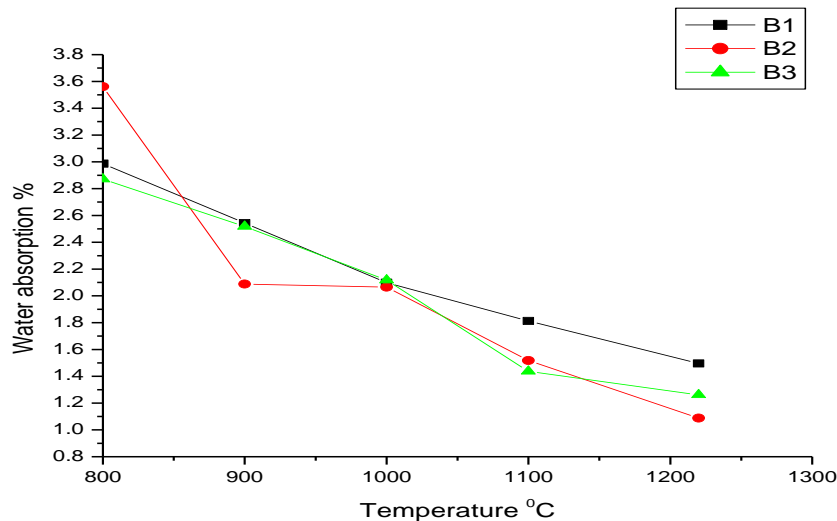
Oxides	ZnO	MnO <sub>2</sub>	Bi <sub>2</sub> O <sub>3</sub>	Co <sub>3</sub> O <sub>4</sub>	Ti <sub>2</sub> O <sub>3</sub>	Cr <sub>2</sub> O <sub>3</sub>	Sb <sub>2</sub> O <sub>3</sub>
B1	97.56	0.5	0.7	0.5	0.7	0.04	---
B2	97.48	0.5	0.7	0.5	0.7	0.12	---
B3	97.40	0.5	0.7	0.5	0.7	0.20	---
Z1	98.06	0.5	0.7	0.5	-	0.12	0.12
Z2	98.12	0.5	0.7	0.5	-	0.06	0.12



**Fig. 1. The position of varistor sample in electric circuit**

### Results and Discussion:

Minimum water absorption appear in samples (B2) and (Z1) equal to 1.088 and 1.153, fired at 1220 °C for 2 hours, respectively. It is evident that better densification and less water absorption are achieved in all mixes fired at 1220 °C for 2 hours as shown in Figs. 2 and 3. Therefore, this temperature was the selected as the proper maturing temperature for all mixes. Above 1220 °C all samples were start of deformation. Water absorption of mixes Z1 and Z2 is less than mixes B1, B2 & B3, i.e. addition of  $\text{Sb}_2\text{O}_3$  in present of  $\text{Co}_2\text{O}_3$ ,  $\text{MnO}_2$ ,  $\text{Sb}_2\text{O}_3$  and  $\text{Cr}_2\text{O}_3$  lead to better densification by minimizing the present of closed pores. Results of firing shrinkage as a function of temperature of different are graphically plotted in Figs. 4 and 5, showed increase of shrinkage with rise in temperature. Maximum values of firing shrinkage were attained in specimens fired at 1220 °C for 2 hours. Higher sintering temperature and longer sintering times give rise to a reduction in bulk densities due to increased amount of porosity between the large grains of ZnO resulting from the rapid grain growth induced by the liquid phase sintering and also the  $\text{Bi}_2\text{O}_3$  losses especially in sintering above 1220 °C.



**Fig. 2. Water absorption of mixes B1, B2 & B3**

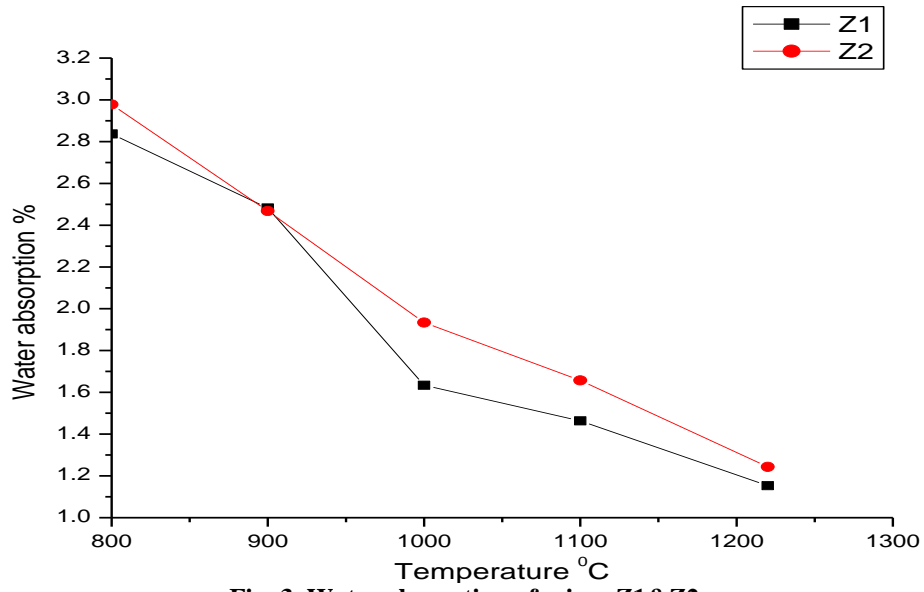


Fig. 3. Water absorption of mixes Z1&Z2

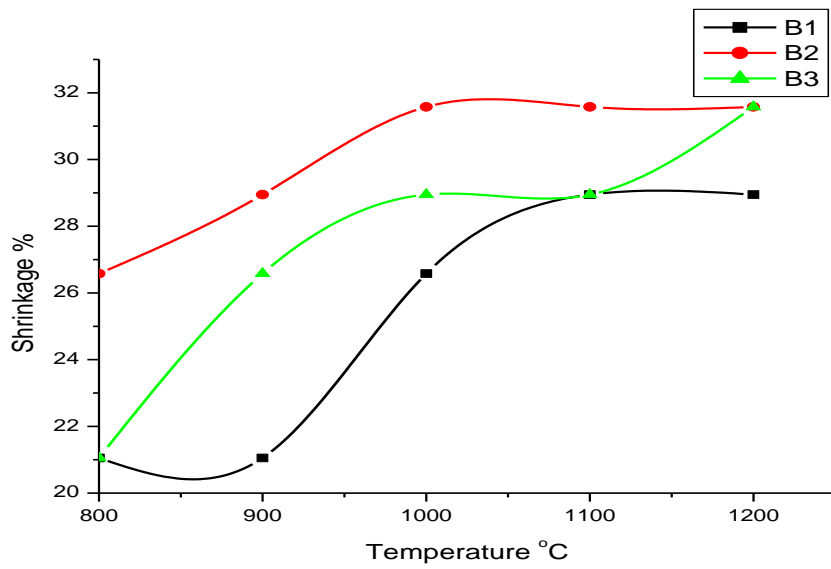
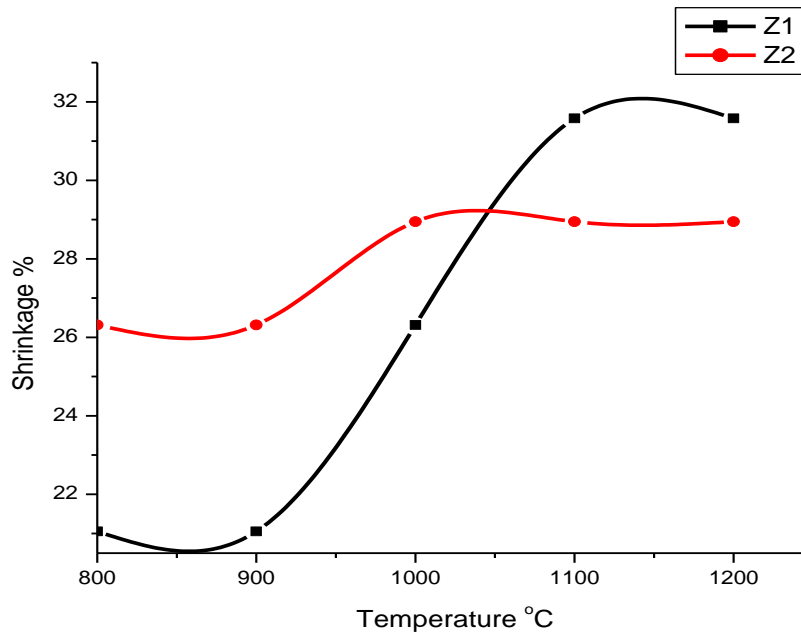


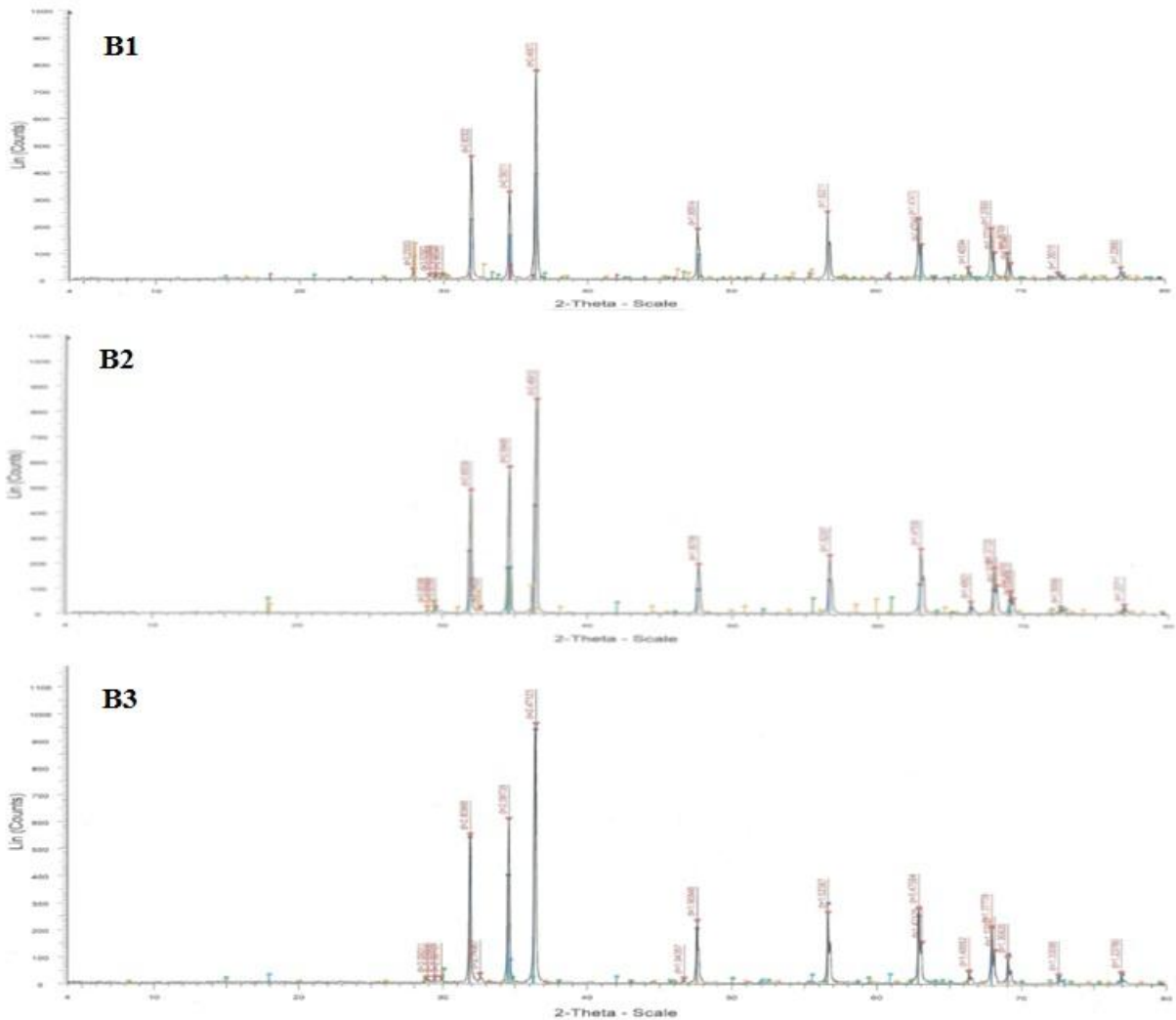
Fig. (4): Firing % shrinkage of B, B2 and B3



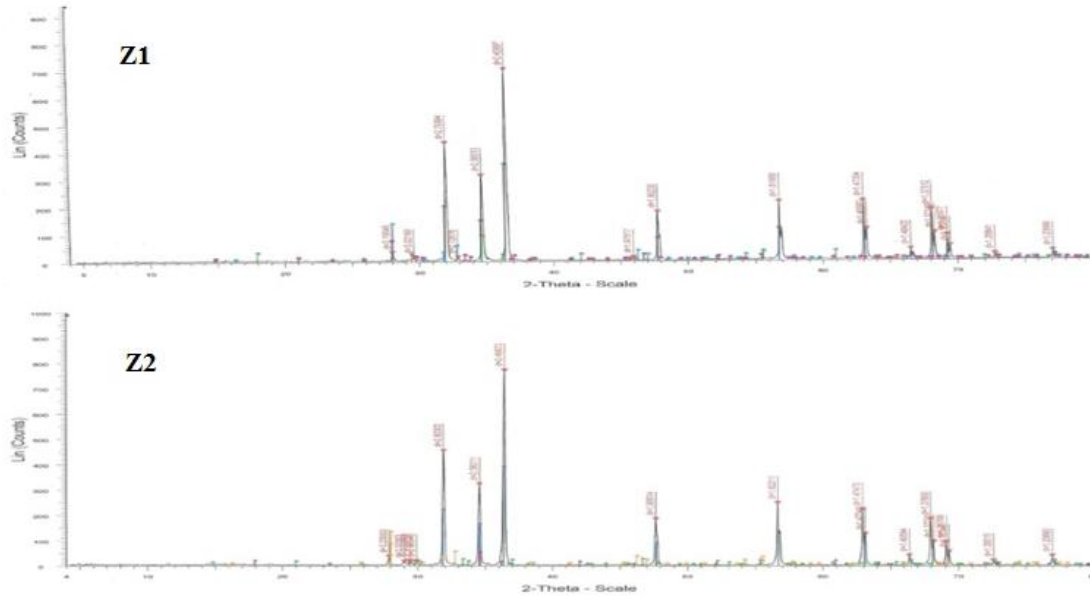
**Fig. (5): Firing % shrinkage of samples Z1 and Z2**

Fig. 6. show the X-ray diffraction patterns of different mixes, namely ( $B_1$ ,  $B_2$  and  $B_3$ ), which containing ZnO,  $Bi_2O_3$ ,  $TiO_2$ ,  $Co_3O_4$ ,  $MnO_2$  and  $Cr_2O_3$ . XRD patterns of sample ( $B_1$ ), in which ZnO diffraction can be detected at about  $2\theta = 36.356$  ( $d = 2.46912 \text{ \AA}$ ),  $47.647$  ( $d = 1.90706 \text{ \AA}$ ) and  $56.666$  ( $d = 1.62307 \text{ \AA}$ ), hexagonal structure, the lattice constants are  $a = b = 3.24880$  and  $c = 5.2054$  (PDF number is (186)-2-47.5807). Hausmannite  $Mn_3O_4$  can be detected at about  $2\theta = 28.93$  ( $d = 3.08386 \text{ \AA}$ ),  $2\theta = 32.579$  ( $d = 2.74628 \text{ \AA}$ ), tetragonal structure, the lattice constants are  $a = b = 5.76500$  and  $c = 9.44200$  (PDF number is (141)-4-313.807). Anatase  $TiO_2$  can be observed at about  $2\theta = 29.496$  ( $d = 3.02590 \text{ \AA}$ ) and  $34.537$  ( $d = 2.59495 \text{ \AA}$ ), tetragonal structure, the lattice constants are  $a = b = 3.80400$  and  $c = 9.61400$  (PDF number is (141)-4-139.119). XRD patterns of sample ( $B_2$ ), in which ZnO can be diffraction detected at about  $2\theta = 31.809$  ( $d = 2.81096 \text{ \AA}$ ),  $34.465$  ( $d = 2.60019 \text{ \AA}$ ),  $36.287$  ( $d = 2.47365 \text{ \AA}$ ),  $47.595$  ( $d = 1.90902 \text{ \AA}$ ) and  $56.648$  ( $d = 1.62354 \text{ \AA}$ ), hexagonal structure, the lattice constants are  $a = b = 3.2488$  and  $c = 5.2054$  (PDF number is (186)-2-47.5807). Also, Hausmannite  $Mn_3O_4$  can be detected at about  $2\theta = 28.891$  ( $d = 3.08792 \text{ \AA}$ ) and  $2\theta = 32.562$  ( $d = 2.74768 \text{ \AA}$ ), tetragonal structure, the lattice constants are  $a = b = 5.76500$  and  $c = 9.44200$  (PDF number is (141)-4-313.807). Zinc Antimony oxide ( $Zn_7Sb_2O_{12}$ ) can be detected at about  $2\theta = 34.465$  ( $d = 2.60019 \text{ \AA}$ ) and  $77.021$  ( $d = 1.23712 \text{ \AA}$ ), cubic structure, the lattice constants are  $a = b = c = 8.59400$  (PDF number is (227)-1-63). XRD patterns of sample ( $B_3$ ), in which ZnO can be detected by the diffraction at about  $2\theta = 31.847$  ( $d = 2.80966 \text{ \AA}$ ),  $2\theta = 34.504$  ( $d = 2.59735 \text{ \AA}$ ),  $2\theta = 36.324$  ( $d = 2.47123 \text{ \AA}$ ),  $2\theta = 47.61$  ( $d = 1.90846 \text{ \AA}$ ),  $2\theta = 56.636$  ( $d = 1.62387 \text{ \AA}$ ), hexagonal structure, the lattice constants are  $a = b = 3.24900$  and  $c = 5.2052$  (PDF number is (186)-2-47.587). Valentinite  $Sb_2O_3$  can be detected at about  $2\theta = 29.389$  ( $d = 3.066 \text{ \AA}$ ),  $2\theta = 46.698$  ( $d = 1.94357 \text{ \AA}$ ), orthorhombic structure, the lattice constants are  $a = 4.92$ ,  $b = 12.46$ ,  $c = 5.62$  (PDF number is (56)-4-344.524). Zinc Antimony oxide ( $Zn_7Sb_2O_{12}$ ) can be detected at about  $2\theta = 72.619$  ( $d = 1.30086 \text{ \AA}$ ),  $2\theta = 76.985$  ( $d = 1.23760 \text{ \AA}$ ), cubic structure, the lattice constants are  $a = b = c = 8.59400$  (PDF number is (227)-1-63). Fig. 7. shows the X-ray diffraction patterns mixes ( $Z_1$ ,  $Z_2$ ) which containing ZnO,  $Bi_2O_3$ ,  $Co_3O_4$ ,  $MnO_2$ ,  $Sb_2O_3$  and  $Cr_2O_3$ . XRD patterns of sample ( $Z_1$ ), in which ZnO can be detected by the diffraction at about  $2\theta = 32.008$  ( $d = 2.79393 \text{ \AA}$ ),  $2\theta = 34.672$  ( $d = 2.58513 \text{ \AA}$ ),  $2\theta = 36.496$  ( $d = 2.45997 \text{ \AA}$ ),  $2\theta = 47.774$  ( $d = 1.90230 \text{ \AA}$ ),  $2\theta = 56.802$  ( $d = 1.61950 \text{ \AA}$ ),  $2\theta = 63.044$  ( $d = 1.47334 \text{ \AA}$ ), hexagonal structure, the lattice constants of ZnO are  $a = b = 3.24170$  and  $c = 5.18760$  (PDF number is (186)-2-47.2110). Bismuth cobalt oxide, can be detected at about  $2\theta = 27.943$  ( $d = 3.19049 \text{ \AA}$ ),  $2\theta = 32.826$  ( $d = 2.72616 \text{ \AA}$ ), tetragonal structure. The lattice constants are  $a = b = 7.7314$  and  $c = 5.6361$ . Zinc Antimony oxide ( $ZnSb_2O_4$ ) can be detected at about  $2\theta = 27.943$  ( $d = 3.19049 \text{ \AA}$ ),  $2\theta = 29.538$  ( $d = 3.02169 \text{ \AA}$ ),  $2\theta = 72.778$  ( $d = 1.2984 \text{ \AA}$ ),  $2\theta = 63.26$  ( $d = 1.46883 \text{ \AA}$ ), tetragonal structure, the lattice constants are  $a = b = 8.94090$  and  $c = 5.9197$  (PDF number is (135)-4-426.783). Zinc Antimony oxide ( $Zn_7Sb_2O_{12}$ ) can be detected at about  $2\theta = 29.538$  ( $d = 1.97517 \text{ \AA}$ ),  $2\theta = 72.778$  ( $d = 1.29841 \text{ \AA}$ ), cubic structure, the lattice constants are  $a = b = c = 8.59400$  (PDF number is (227)-1-63). XRD patterns of sample ( $Z_2$ ), in which ZnO can be detected by the

diffraction at about  $2\theta = 31.901$  ( $d = 2.80302 \text{ \AA}$ ),  $2\theta = 34.576$  ( $d = 2.59211 \text{ \AA}$ ),  $2\theta = 36.393$  ( $d = 2.46673 \text{ \AA}$ ),  $2\theta = 47.671$  ( $d = 1.90614 \text{ \AA}$ ),  $2\theta = 56.702$  ( $d = 1.62211 \text{ \AA}$ ),  $2\theta = 63.18$  ( $d = 1.47049 \text{ \AA}$ ), hexagonal structure, the lattice constants of ZnO are  $a = b = 3.24170$  and  $c = 5.18760$  (PDF number is (186)-2-47.2110). Bismuth cobalt oxide, can be detected at about  $2\theta = 27.853$  ( $d = 3.20053 \text{ \AA}$ ),  $2\theta = 47.671$  ( $d = 2.98540 \text{ \AA}$ ), tetragonal structure, the lattice constants are  $a = b = 7.7314$  and  $c = 5.6361$ . Zinc Antimony oxide ( $\text{ZnSb}_2\text{O}_4$ ) can be detected at about  $2\theta = 27.853$  ( $d = 3.2005 \text{ \AA}$ ),  $2\theta = 29.905$  ( $d = 2.98540 \text{ \AA}$ ),  $2\theta = 62.979$  ( $d = 1.47470 \text{ \AA}$ ), tetragonal structure, The lattice constants are  $a = b = 8.94090$  and  $c = 5.9197$  (PDF number is (135)-4-426.78). Zinc Antimony oxide ( $\text{Zn}_7\text{Sb}_2\text{O}_{12}$ ) can be detected at about  $2\theta = 29.41$  ( $d = 3.03458 \text{ \AA}$ ),  $2\theta = 34.576$  ( $d = 2.59211 \text{ \AA}$ ), cubic structure, the lattice constants are  $a = b = c = 8.59400$ .

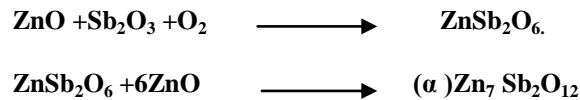


**Fig. 6. XRD of mixes B1,B2&B3**

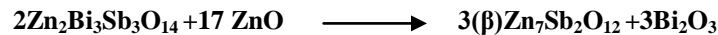


**Fig. 7. XRD of mixes Z1&Z2**

., SEM of mix B1, Fig. 8, shows two phases, ZnO grains and intergranular phase triple point, also  $\text{TiO}_2$ ,  $\text{Co}_2\text{O}_3$  and  $\text{Cr}_2\text{O}_3$  go into solid solution in the ZnO grains also Bi-rich phase in the triple point and increase the presence of liquid phase (melt liquid phase) on the grain boundary. Fig. 9. SEM of mix B2, shows different phase of ZnO grain, the exsolution of Bi-rich phase along the grain boundary, in various size. SEM of mix Z2 present in Fig. 10. shows the presence of a spinal phase between ZnO and  $\text{Sb}_2\text{O}_3$  ( $\text{Zn}_7\text{Sb}_2\text{O}_{12}$ ), intergranular layers, a Bi-rich phase, and triple points. During first stage of the sintering heterogeneous reactions from the powder particles lead to spinal phases [37] as shown in the following equations:



In a second stage a low melting point eutectic between ZnO,  $\text{Bi}_2\text{O}_3$  and  $\text{Sb}_2\text{O}_3$  is formed above  $700^\circ\text{C}$ . The third stage, liquid phase densification at the sintering temperature is the step where the main ZnO grain growth occurs. At this temperature the ZnO grain are still small but tend to grow with the temperature despite the presence of spinal phases which hinder ion transfer. As a result the grain growth is limited by pinning migrating ZnO grain boundaries. Another reaction leads to the pyrochlore phase ( $\text{Zn}_2\text{Bi}_3\text{Sb}_3\text{O}_{14}$ ) formation which is rather unstable and decomposes during the early stage of sintering by solid-state reaction of ZnO with pyrochlore ( $\text{Zn}_2\text{Bi}_3\text{Sb}_3\text{O}_{14}$ ) according to ref [38]:



Which gets free liquid  $\text{Bi}_2\text{O}_3$ -rich phase above  $950^\circ\text{C}$ . During cooling, Bi-rich phase recedes to multigrain junctions. This operation is critical since extra bismuth concentration is rather detrimental to produce good varistor electrical properties [39,40]. The spinal phases, embedded in the liquid phase, are expelled to the multi-junctions. This creates a microstructure constituted of ZnO grains where the space at multiple-grain junctions and partially surrounding ZnO grains are filled by bismuth rich phase.



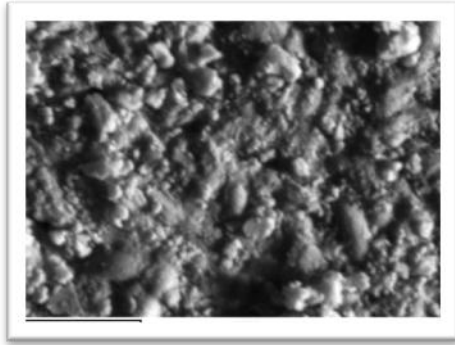


Fig. 8. SEM of mix B<sub>1</sub> , thermally etched X=3000.

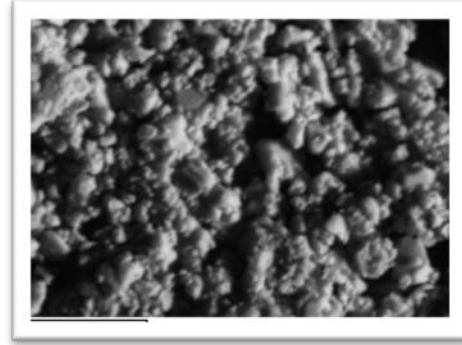
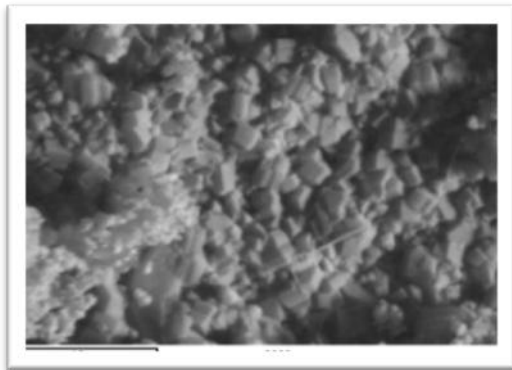
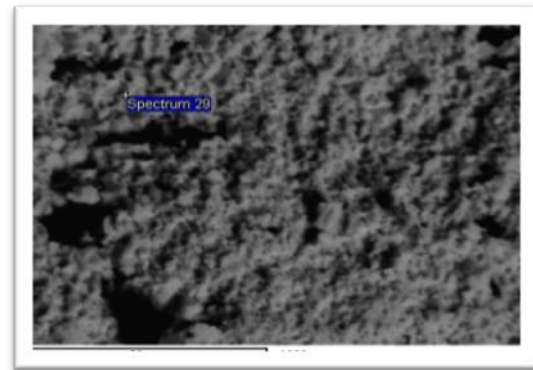


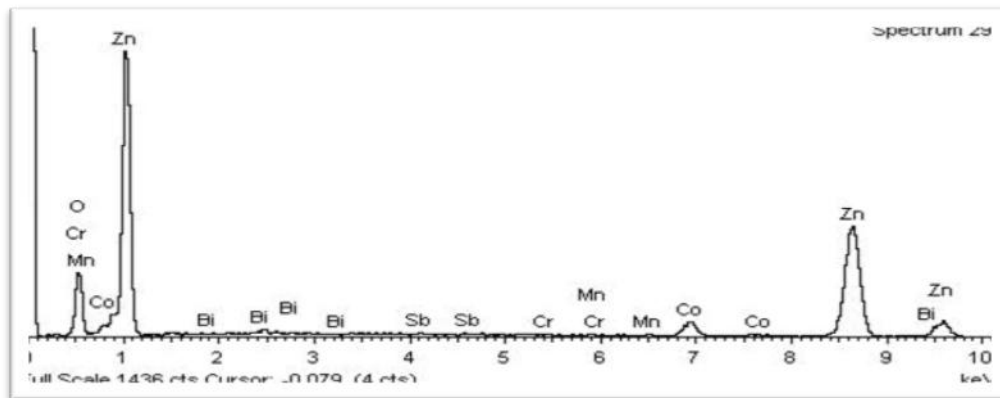
Fig. 9. SEM of mix B<sub>2</sub> ,thermally etched, X=3000.



a



b



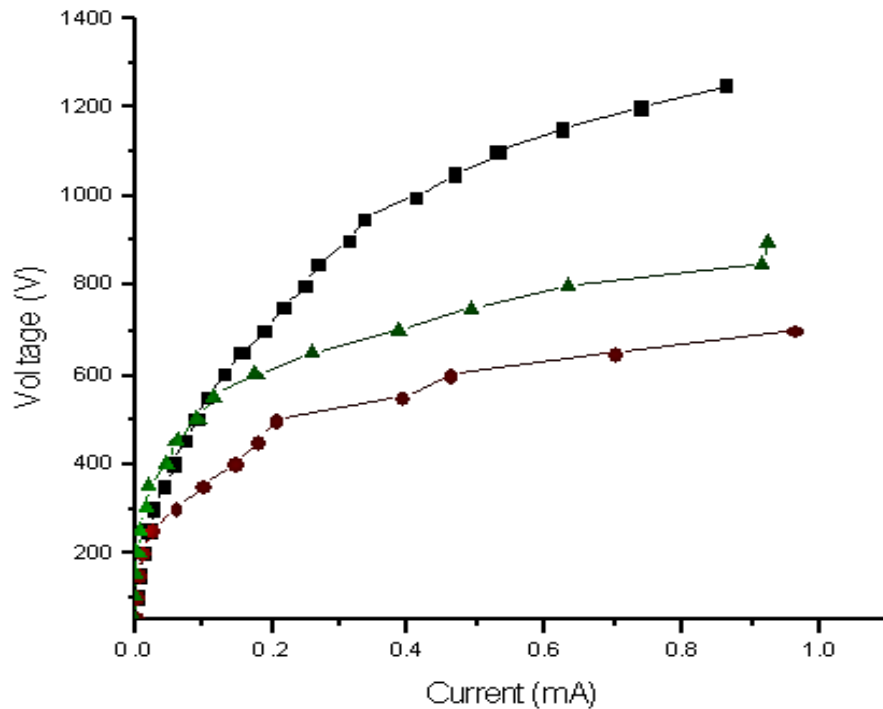
(c)

Fig. 10 SEM and XRD of mix Z<sub>2</sub>, (a) thermally etched, ZnO grains in preferred orientation. (b) Thermally etched, of mix Z<sub>2</sub> shows the random distribution of minor elements. (c) EDAX of Z<sub>2</sub>, shows the concentration of Bi<sub>2</sub>O<sub>3</sub>, Sb<sub>2</sub>O<sub>3</sub>, Cr<sub>2</sub>O<sub>3</sub>, MnO<sub>2</sub> with ZnO and Co<sub>3</sub>O<sub>4</sub> in intergranular.

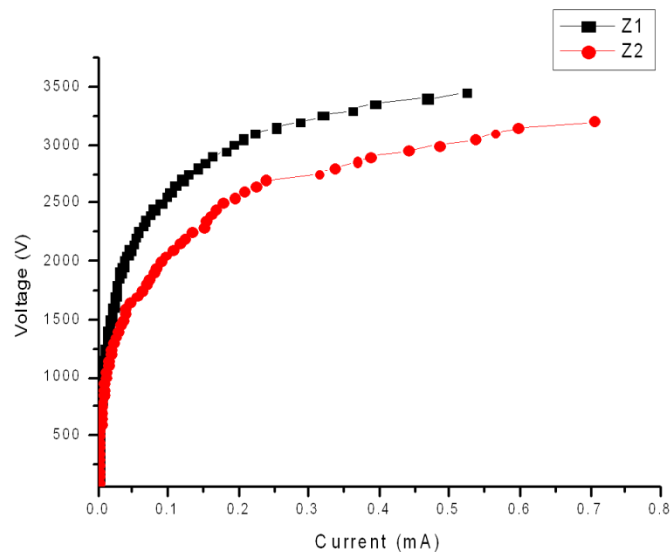
The relation between I and V for the different mixes show very good plateau in (I-V) relation which are present in Figs. (11,12). The characteristic curves of different groups are greatly divided into two regions, that is pre break down at low voltage region and an off-state and nonlinear properties as an on-state high voltage region, the sharper the knee of the curves between the two regions, the better the nonlinearity. The non-linear behavior in ZnO-base materials is attributed to the formation of interface states in the band gap of ZnO which lead to the development of potential barriers to electrical conduction at ZnO grain boundaries. Although the intrinsic defects of zinc oxide can account themselves for the formation of such potential barriers in pure ZnO [41], the presence of external dopants



located both at the grain boundaries and inside the grains is expected to alter the local configuration, so affecting the non-linear behavior of the system.



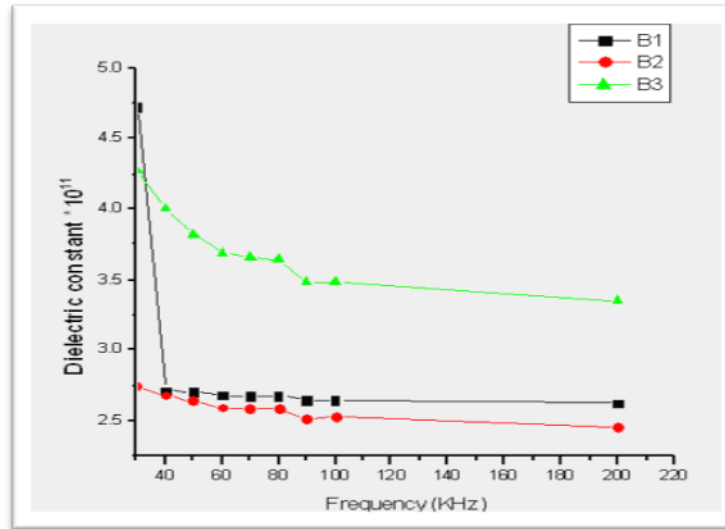
**Fig. 11. I-V Characteristics of mixes B1 (■), B2 (●) and B3 (▲).**



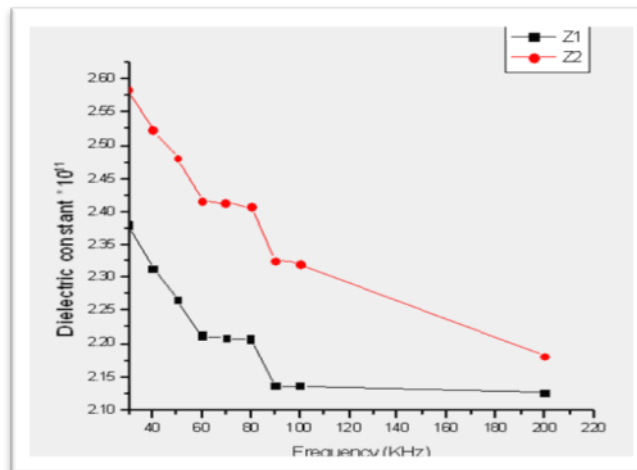
**Fig. 12. I-V Characteristics of mixes Z1 and Z2**

The results of dielectric constant as a function of frequency at room temperature of different mixes are graphically plotted in Figs. (13 and 14). A decrease in capacitance and consequently in dielectric constants for different mixes was observed. This may be explained in the light of microstructure formed of semi-conductive ZnO grains surrounded by insulating glassy phase which is similar to that of grain boundary layer capacitors as a result the

observed dielectric constant increased with increase in dopant oxides. The relation between resistivity and frequency for the different mixes present

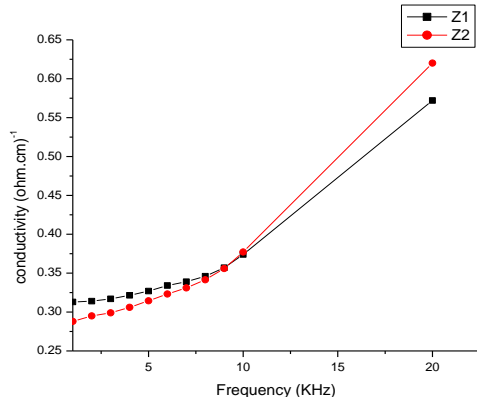


**Fig.13.**Dielectric constant as function of frequency of mixes B1,B2&B3

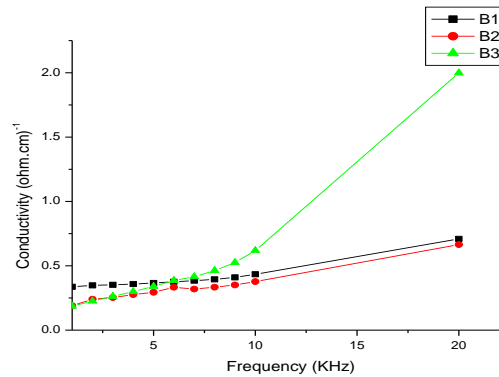


**Fig.14.**Dielectric constant as function frequency of mixes Z1&Z2

The relation between conductivity and frequency for different mixes are shown in Figs. (15,16). The conductivity increases with increasing frequency at room temperature. This may be attributed to the increase in the number of dipoles. The increase of frequency raised the conductivity because it increases the ionic response to the field again this is related to intergranular material at the field again this is related to intergranular material at any particular temperature. These effect are associated with polarization currents arising from trapping states of various kinds and densities. The increase in frequency raised the conductivity as a result of the increase in ionic response to the field again this is related to inter-granular material.



**Fig. 15. AC Conductivity as a function of frequency of mixes Z1 and Z2**



**Fig. 16. AC Conductivity as a function of frequency of mixes B1, B2 and B3**

## References

- [1] D C. Look 2001 Mater. Sci. Eng. B 80 ,383
- [2] U Ozgür, Y I Alivov, C Liu, A Teke, M A Reshchikov, S Dogan, VAvrutin, S-J Cho and H Morkoc, 2005 J. Appl. Phys. 98, 041301
- [3] S B Ogale 2005 Thin Films and Heterostructures for Oxide Electronics (New York: Springer)
- [4] H N Nickel and E (ed) Terukov 2005 Zinc Oxide- A Material for Micro- and Optoelectronic Applications (Netherlands: Springer)
- [5] C Jagadish and S J (ed) Pearton 2006 Zinc Oxide Bulk, Thin Films, and Nanostructures (New York: Elsevier)
- [6] D G Thomas 1960 J. Phys. Chem. Solids 15 ,86
- [7] A Mang ,K Reimann and St R ubenacke 1995 Solid State Commun. 94, 251
- [8] D C Reynolds ,D C, Look, B Jogai B, CW Litton, G Cantwell and W C Harsch 1999 Phys. Rev. B 60, 2340
- [9] Chen Y, Bagnall D M, Koh H-J, Park K-T, Hiraga K, Zhu Z-Q and Yao T 1998 J. Appl. Phys. 84, 3912
- [10] V Srikant and D R Clarke 1998 J. Appl. Phys. 83 ,5447
- [11] D C Reynolds , D C Look and B Jogai 1996 Solid State Commun. 99, 873
- [12] D M Bagnall D M, Y F Chen, Z Zhu, T Yao, S Koyama, M Y Shen and T Goto 1997 Appl. Phys. Lett. 70 ,2230
- [13] M E (ed) Brown 1957 ZnO—Rediscovered (New York: The New Jersey Zinc Company)
- [14] K. Al Abdullah, M.D. I Termanini, F. Alhaj Omar LHAJ Omar Energy Procedia 18 ( 2012 ) 867 – 878
- [15] F.A. Kröger 1974 The Chemistry of Imperfect Crystals, North-Holland, Amsterdam, 743.
- [16] M.H. Sukkar, H.L. Tuller 1983 Defect equilibria in ZnO varistor materials, in: M.F. Yan, A.H. Heuer (Eds.), Advances in Ceramics, vol. 7, The American Ceramic Society, , p. 71.
- [17] J. Han, P. Mantas, A.M.R. Senos 2002 J. Eur. Ceram. Soc. 22,49.
- [18] L. Harry, Tuller, 1999 J. Electroceram. 4 , 33
- [19] E. Olsson, G. Dunlop, R. Osterund 1993 , J. Am. Ceram. Soc. 76 , 65.
- [20] T.K. Gupta, W.D. Straub 1990 , J. Appl. Phys. 68 , 845.
- [21] F. Greuter, G. Blatter 1990 Semicond. Sci. Technol. 5 , 111.
- [22] H.A. Harwig, A.G. Gerrards 1978 J. Solid State Chem. 26 , 265.
- [23] J. Wong 1974 , J. Am. Ceram. Soc. 57 , 357.
- [24] J. Kim, T. Kimura, T. Yamaguchi, 1989 J. Am. Ceram. Soc. 72 , 1390
- [25] P. Durán, F. Capel, J. Tartaj, C. Moure 2001 , J. Am. Ceram. Soc. 84, 1661.
- [26] A. Iga, M. Matsuoka, T. Masuyama 1976 Jpn. J. Appl. Phys. 15 ,1161.
- [27] J. Wong, W.G. Morris 1974 , Ceram. Bull. 53 , 816.
- [28] N. Daneu, A. Raenik, S. Bernik, D. Kolar 2000 J. Am. Ceram. Soc. 83 , 3165.
- [29] E. Olsson, G.L. Dunlop, R. Osterlund, J. Appl. Phys. 66 (1989) 5072.
- [30] E. Olsson, L.K.L. Falk, G.L. Dunlop, R. Osterlund, 1985 J. Mater. Sci. 20 4091.
- [31] L.M. Levinson, H.R. Philip 1975 , J. Appl. Phys. 46 , 1332.
- [32] W.G. Morris 1973 , J. Am. Ceram. Soc. 56 , 360.
- [33] L.M. Levinson, H.R. Philipp 1986 Zinc oxide varistor — a review, Ceram. Bull. 65 (4), 639 .
- [34] T.K. Gupta 1990 Application of zinc oxide varistor, J. Am. Ceram. Soc. 73 (7) , 1817.

- [35] S.A. Pianaro, P.R. Bueno, E. Longo, J.A. Varela 1999, Microstructure and electric properties of a SnO<sub>2</sub> based varistor, *Ceram. Int.* 25 , 1.
- [36] Annual book of ASTM standards, American society for testing and material, 1966.
- [37] M. Inada 1979, *Jpn. J. Appl. Phys.*, 18, 1439-1446 .
- [38] M. Inada 1980, *Jpn. J. Appl. Phys.*, 19, 409.
- [39] K. I. Kobayashi, O. Wada, M. Kobayashi, Y. Takada 1998 , *J. Am. Ceram. Soc.*, 81, 2071.
- [40] T. Asokan 1987 , *Br. Ceram. Trans. J.*, 80, 187.
- [41] V. Srikant, V. Sergio, and D. R. Clarke 1995 , *J. Am. Ceram. Soc.*, 78, 1935.